



Final Product Change Notification

201901014F01

Issue Date: 09-Feb-2019

Effective Date: 10-May-2019

Dear *Tracy Hoglin*,

Here's your personalized quality information concerning products Digi-Key purchased from NXP. For detailed information we invite you to view this notification online

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QUALITY

Management Summary

Microcontroller products LPC5410xUK49 version "C" includes a die revision to fix errata issues and an upgraded bump process.

Change Category

<input type="checkbox"/> Wafer Fab Process	<input checked="" type="checkbox"/> Assembly Process	<input checked="" type="checkbox"/> Product Marking	<input type="checkbox"/> Test Location	<input checked="" type="checkbox"/> Design
<input type="checkbox"/> Wafer Fab Materials	<input checked="" type="checkbox"/> Assembly Materials	<input checked="" type="checkbox"/> Mechanical Specification	<input type="checkbox"/> Test Process	<input type="checkbox"/> Errata
<input type="checkbox"/> Wafer Fab Location	<input type="checkbox"/> Assembly Location	<input type="checkbox"/> Packing/Shipping/Labeling	<input type="checkbox"/> Test Equipment	<input type="checkbox"/> Electrical spec./Test coverage
<input type="checkbox"/> Firmware	<input type="checkbox"/> Other			

LPC5410xUK49 in WLCSP49 Package Change from Rev "B" to Rev "C"

Description of Change

Microcontroller products LPC5410xUK49 in WLCSP49 package will change from version "B" to version "C". Changes included a die revision to fix errata issues and an upgraded bump process.

The following functional changes were made to product version "C":

- IRC frequency tolerance improvement over temperature to resolve errata IRC.1 as defined in the device errata sheet.
- System clock frequency improved to resolved errata Frequency.1 as defined in the device errata sheet.

The following bump process changes were made to product version "C":

- Under Bump Metal (UBM) and Re-Distribution Layer (RDL) change from a sputter to a plated process.
- Back side protection (BSP) material changes from 40um to 25um thickness.

- Overall maximum package thickness changes from 0.58mm to 0.565mm (see package drawing in attached datasheet).

A revised data sheet, LPC5410x v2.10 is available at <https://www.nxp.com/docs/en/data-sheet/LPC5410X.pdf>.

Reason for Change

- 1) To fix errata IRC.1 and Frequency.1.
- 2) The sputter UBM process is outdated and has been obsoleted by the assembly vendor. The assembly process is being upgraded to the current process already qualified by the LPC5411xUK49.

Identification of Affected Products

Top side marking

The change applies to product version "C" visible on the top side marking.

Product Availability

Sample Information

Samples are available upon request

Production

Planned first shipment 10-May-2019

Anticipated Impact on Form, Fit, Function, Reliability or Quality

Product overall height is reduced by 15um due to change in back side protection thickness.

Product functionality changes to fix errata issues IRC.1 and Frequency.1.

Data Sheet Revision

A new datasheet will be issued

Disposition of Old Products

Existing inventory will be shipped until depleted

Timing and Logistics

In compliance with JEDEC J-STD-046, your acknowledgement of this change is expected by 11-Mar-2019.

Contact and Support

For all inquiries regarding the ePCN tool application or access issues, please contact NXP "Global Quality Support Team".

For all Quality Notification content inquiries, please contact your local NXP Sales Support team.

For specific questions on this notice or the products affected please contact our specialist directly:

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Position Senior Quality Engineer
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Changed Orderable Part#	Changed Part 12NC	Changed Part Number	Changed Part Description	Package Name	Status	Product Line
LPC54101J256UK49Z	935305133019	LPC54101J256UK49	32-bit ARM M4	UNCASED	RFS	MCUs
LPC54102J512UK49Z	935305139019	LPC54102J512UK49	32-bit ARM M4	UNCASED	RFS	MCUs